## Notice of References Cited Application/Control No. 10/057,926 Examiner Brian J. Detwiler Applicant(s)/Patent Under Reexamination YAMAGUCHI ET AL. Art Unit Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,437,786	08-2002	Yasukawa, Masaaki	345/474
	В	US-6,247,076	06-2001	Ono, Hiroshi	710/65
	С	US-6,108,667	08-2000	Clark et al.	707/200
	D	US-6,061,473	05-2000	Chen et al.	382/235
	Е	US-5,987,323	11-1999	Huotari, Seppo	455/433
	F	US-5,940,756	08-1999	Sibecas et al.	455/426.1
	G	US-5,933,247	08-1999	Shibata, Hiroshi	358/404
	Н	US-5,463,776	10-1995	Voigt et al.	707/101
	ı	US-2002/0049071	04-2002	Bjorn, Michael	455/550
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 05216885 A	08-1993	Japan	IWAMOTO, KEIMEI	G06F 15/20
	0					
	Р					
	Q					
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	U						
	V						
	w						
	х						

A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.